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Silver oxalate-based solders: New materials for high thermal conductivity microjoining

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Micrometric oxalate powders can be decomposed starting from temperatures as low as 90 °C, leading to the formation of temporary nanometric grains of metallic silver with a high propensity for sintering. The decomposition being highly exothermic, this additional energy favours the sintering, i.e. the soldering, process. Solders processed at 300 °C and very low pressure (<0.5 MPa) displayed a thermal conductivity close to 100 W m⁻¹ K⁻¹, making silver oxalate very promising for safe, moderate temperature and very low pressure bonding.

Keywords: Silver oxalate; Microelectronic packaging; Joining; Soldering; Thermal conductivity

Engineering processes often require the joining together of material surfaces using gluing, soldering and brazing [1]. Such joining operations generally involve the supply of a third material (soldering metal, polymeric glue), which must first ensure the bonding between two surfaces, but which can also be dedicated to other functions, such as electrical or thermal conductivity, optical transparency or reflectivity [1]. For interconnections in electronics systems, only a moderate mechanical threshold of bonding is required, but very high electrical or thermal conductivity is often looked for [2,3]. For these reasons, highly conductive metals, such as Cu, Ag, Au and some of their alloys, are used as brazing materials [3,4]. However, to benefit from the best electrical or thermal properties of such metals or alloys, they have to be as dense as possible at the end of the brazing operation. This is a difficult challenge, because the brazing operation generally has to be a quite quick (a few minutes) and moderate temperature (≤300 °C) process, using only light contact pressures between the two pieces for assembly (typically lower than 10 MPa). Indeed, high temperature and/or pressure processes could cause irreversible damage or accelerated ageing effects to the electronic devices.

To prevent such damage for both dies and substrates, a lot of work has recently been carried out to find low temperature soldering processes and materials [5–10]. One of the driving ideas is to benefit from the strong decrease in the melting temperature when the particle size is reduced below about 10 nm [11–13]. Because the sintering generally occurs at an absolute temperature close to 80% of the melting point, this decrease makes low-temperature soldering easier. For gold or silver nanowires, welding can even occur close to room temperature [7,9].

The preparation of silver nanoparticles suspensions or pastes has thus attracted a great deal of attention [5,6,14,15] with regard to developing new joining products. However, such particles must be coated with
organic compounds to avoid aggregation. Moreover, the industrial use of nanoparticles poses potential health and security problems. Research must thus be carried out to avoid nanoparticles being used in brazing pastes or suspensions. For this reason, combining micrometric silver particles with sintering additives has already been proposed [16].

A new route to obtain highly thermally conductive silver solder at low temperature and pressure is to use suspensions or pastes made of micrometric silver oxalates. Such Ag₂C₂O₄ salts can be decomposed into metallic silver below 200 °C in air, or under an inert or reducing atmosphere [17,18]. During this reaction, silver nanoparticles with a high propensity to sinter are created [19]. The oxalate decomposition is highly exothermic (ΔH close to −122 kJ mol⁻¹) [18], providing additional energy locally, which also favours the sintering process. To really take advantage of such oxalic precursors, it is better to prepare particles by chemical precipitation of a soluble salt in oxalic acid dissolved in a hydro-alcoholic medium. By this route, small, well-shaped particles are obtained that can be more easily dispersed in a liquid for suspension or paste manufacturing.

Silver oxalates were prepared as follow. A concentrated solution of silver nitrate was reacted with oxalic acid solution to produce a precipitate of oxalate. The silver nitrate was initially dissolved in a mixture of water (10% vol.) and ethylene glycol (90% vol.). For the samples named LE09, the oxalic acid was dissolved in a mixture of ethyl alcohol (95%) and water (5%). The solvent of the oxalic acid for the samples named LE21, was butanol. The salt solution was then introduced dropwise into the oxalic acid solution. The obtained precipitate was washed several times in deionized water and suspensions were centrifuged to separate the powder from the liquid. Finally, the powder was quickly dried under a primary vacuum and kept away from light due to photosensitive properties. The size of the particles was influenced by the dielectric constant of the solvent. Generally, the size decreases when the dielectric constant of the solvent of oxalic acid is lowered [20]. The use of hydro-alcoholic solvent thus allows small particles to be obtained (Fig. 1), which can be decomposed quickly and easily. The smallest particles, about 1 μm, were observed for the experiment carried out in butanol (LE21 powder). Consequently, the LE21 sample was used to prepare the brazing suspensions while the LE09 sample, containing acicular particles between 5 and 10 μm, was used to illustrate the phenomena occurring during decomposition. The same decomposition phenomena were observed for both samples, but the bigger size of particles in the LE09 sample allowed easier electron microscopy imaging of the uncoated low conductive powder.

The prepared powders display the same X-ray diffraction pattern as the one given by the JCPDS file No. 00-022-1335, showing that they are made of a single phase of silver oxalate. The thermal decomposition of one molecule of silver oxalate gives two molecules of metallic silver and two molecules of gaseous CO₂, according to the chemical reaction [18]:

\[
\text{Ag}_2\text{C}_2\text{O}_4 \rightarrow 2\text{Ag} + 2\text{CO}_2
\]  

(1)

The mass loss after decomposition was equal to 29%, which is the same as the theoretical loss calculated from the chemical reaction (1). The decomposition is a highly exothermic reaction, and can lead to an explosion when the oxalate is quickly heated. However, for a heating rate lower than about 10 °C min⁻¹, it is possible to avoid an explosion and to stop the reaction in progress at different stages, thus allowing the main features of the decomposition mechanism to be characterized. Oxalate samples were then heated at a constant rate of 5 °C min⁻¹ to different temperatures before being rapidly cooled. Scanning electron microscopy (SEM) clearly shows the beginning of the decomposition, which starts at a temperature close to 90 °C with the formation of metallic nanometric-size (below 10 nm) grains on the particle edges (Fig. 2a). At 120 °C, numerous spherical or spike-shaped metallic grains were observed on each oxalate particle (Fig. 2b). They are also mainly located on the silver oxalate edges and on surface defects. Indeed, the nucleation activation energy is lower in these areas. Due to the nanometric size of the grains and their related high reactivity, a small increase in temperature to 140 °C favours their growth and their coalescence (Fig. 2c), leading to the loss of the acicular shape of the precursor particles. At about 200 °C, when the decomposition has finished, spongy metallic grains replace the initial oxalate particles (Fig. 2d). These are partially linked to other decomposed particles by small metallic bridges. Theses bridges reveal the inter-particle sintering process, which can be enhanced at higher temperatures or when the powder is submitted to a small uniaxial pressure.

In order to make a solder paste, suspensions were prepared by mixing silver oxalate powder with pure ethylene glycol in an ultrasonic bath. These were then deposited on the whole surface of a 4 × 4 mm² gold-plated alumina

![Figure 1](image1.png) Different morphologies of silver oxalate particles: LE21 sample prepared in butanol (a) and LE09 prepared in ethyl alcohol (b).

![Figure 2](image2.png) Silver nanoparticles growing and sintering on the surface of LE09 oxalate particles: 90 °C (a), 120 °C (b), 140 °C (c) and 220 °C (d).
substrate, mimicking a high-power microchip as used for space applications. After drying, the oxalate film thickness was close to 50 μm. This "chip" was then covered by another 10 × 10 mm² golden alumina sheet, to which a pressure of <0.5 MPa was applied. The whole assembly was finally heated in air up to 300 °C and then cooled to room temperature. After this heat treatment, the two gold-plated pieces were strongly joined by a 30 μm metal film. The average shear stress required to separate the two brazed pieces was close to 3 MPa, which meets all the requirements in reference to the method MIL Std 883 for die shear strength [21]. The silver solder was controlled by scanning acoustic microscopy. No voids, cracks or thickness heterogeneities were observed by this technique, revealing a good homogeneity of the solder layer.

Due to the CO₂ release during the decomposition and the resulting loss of material, the sintering of silver particles at 300 °C is not complete and a porous metallic network is formed. To reveal this network and to observe its intersection with the bonded parts, the following experiment was carried out. One of the gold-plated alumina substrates was replaced by a very smooth glass slide. Due to both its very small roughness (Ra lower than 0.5 nm) and its chemical nature (oxide material), this slide was only slightly bonded to the silver after the soldering operation and the two materials were easily separated by a moderate torque. Very few silver grains remained attached to the surface of the glass after splitting, because the bonds between the silver and the glass were much weaker than those inside the solder. SEM and AFM micrographs of the solder can thus show the porous silver network formed at 300 °C (Fig. 3). Moreover, close observation revealed very flat surfaces on the upper part of some silver grains, which were all located in the same plane. This plane marked the interface between the solder and the glass slide. By image analysis, the surface area of the so-called “flat surfaces” can be measured and its ratio with the total surface area observed, allowing the porosity ρ of the silver network to be assessed. ρ was found to be around 80%.

If we assume that \( K_{\text{solder}} = K_{\text{Ag}}(1 - \rho) \), with \( K_{\text{solder}} \) and \( K_{\text{Ag}} \) being the thermal conductivity of the solder and of the bulk silver respectively, \( K_{\text{solder}} \) can be estimated to be \( (1 - 0.8) \times 429 \approx 85 \text{ W m}^{-1} \text{ K}^{-1} \). This value gives a preliminary rough value of the thermal conductivity, which can be obtained with a silver oxalate-based solder.

To obtain a more precise value and to avoid possible artifacts due to the difference between silver–glass and silver–gold interfaces, thermal conductivity measurements were performed by micro-Raman infrared thermography on active assemblies, in which a high-power microchip was brazed onto a highly conductive gold-plated substrate. For this kind of sample, a very low pressure of <0.5 MPa was applied on the edges of the chip, leaving the active part free. An infrared scan shows a homogeneous temperature repartition in the transistor channel, indicating that the solder layer does not have any major voids. The micro-Raman spectroscopy enables a more precise spatial resolution and was carried out by measuring the temperature and dissipated power of the transistor for each polarization point in DC mode. This information enabled the thermal conductivity of the brazing layer to be calculated, by comparing the measured performance to the computer simulation of the system behaviour. Thermal expansion of the layer and the piezoelectric strain were taken into account. This method gave a thermal conductivity of around 100 W m⁻¹ K⁻¹, which is close to our previous estimation. This value is much higher than those obtained with the widely used AuSn space electronics solder, which are limited to about 57 W m⁻¹ K⁻¹ [22], and is, to our knowledge, the highest obtained at moderate temperature (≤300 °C) and very low pressure (<0.5 MPa).

It is interesting to note that, when the pressure is increased up to only 3 MPa, the porosity drops to about 60%, leading to an estimated value of the thermal conductivity higher than 150 W m⁻¹ K⁻¹.

In summary, this work highlights the potential of silver oxalates precipitated in hydro-alcoholic media as a new soldering material. Such oxalates can be advantageously used to make high thermal conductivity interfaces. For the first time, a solder having a conductivity of about 100 W m⁻¹ K⁻¹, has been obtained at moderate temperature (≤300 °C) and very low pressure (<0.5 MPa). The performances of the silver oxalate-based solder are explained by the creation of small nanoparticles during thermal decomposition, which considerably improve the material’s reactivity. The heat produced by the decomposition also makes the sintering of silver particles easier. In addition, as the initial and final material is of micrometric size, this solder does not require the application of the binding safety procedures required for nanoparticle manipulation, which is a very important advantage of the oxalates compared to products made of silver nanoparticles.

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